

DESCRIPTION

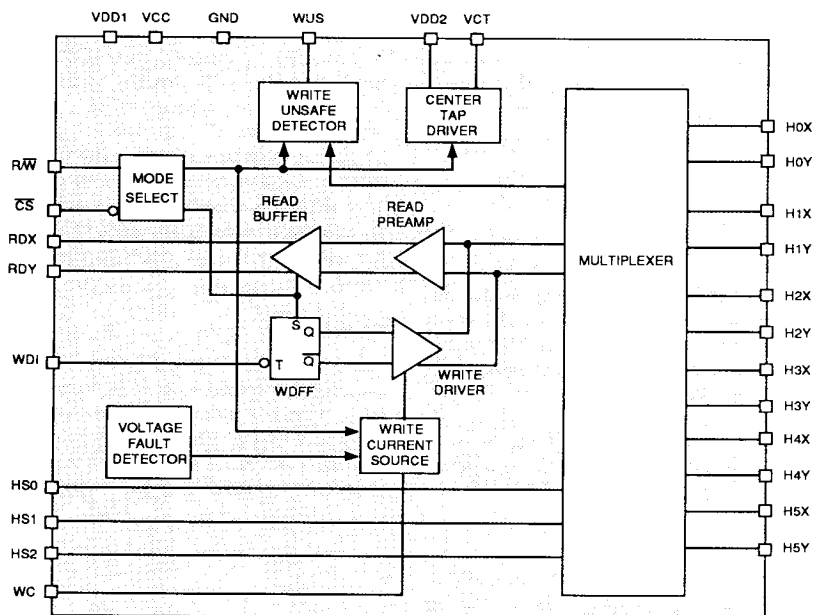
The SSI 32R510/510AR, 32R514/514R Read/Write devices are bipolar monolithic integrated circuits designed for use with center-tapped ferrite recording heads. They provide a low noise read amplifier, write current control and data protection circuitry for as many as six channels. The R option provides internal 750Ω damping resistors. Power supply fault protection is provided by disabling the write current generator during power sequencing. System write to read recovery time is significantly improved by controlling the read channel common mode output voltage shift in the write mode. They are available in a variety of package and channel configurations.

FEATURES

June, 1990

- **High performance:**
 - Read mode gain = 100 V/V (32R510A)
= 150 V/V (32R514)
 - Input noise = 1.5 nV/√Hz max.
 - Input capacitance = 20 pF max.
 - Write current range = 10 mA to 40 mA
- Enhanced system write to read recovery time
- Power supply fault protection
- Plug compatible to the SSI 32R117
- Designed for center-tapped ferrite heads
- Programmable write current source
- Write unsafe detection
- TTL compatible control signals
- +5V, +12V power supplies

BLOCK DIAGRAM



CAUTION: Use handling procedures necessary for a static sensitive component.

SSI 32R510A/510AR

32R514/514R

2, 4, 6-Channel

Read/Write Devices

CIRCUIT OPERATION

These devices address up to six center-tapped ferrite heads providing write drive or read amplification. Head selection and mode control is accomplished with pins HS_n, $\overline{\text{CS}}$, and $\text{R}/\overline{\text{W}}$, as shown in Tables 1 & 2. Internal resistor pullups, provided on pins $\overline{\text{CS}}$ and $\text{R}/\overline{\text{W}}$, will force the device into a non-writing condition if either control line is opened accidentally.

TABLE 1: Mode Select

$\overline{\text{CS}}$	$\text{R}/\overline{\text{W}}$	MODE
0	0	Write
0	1	Read
1	X	Idle

TABLE 2: Head Select

HS2	HS1	HS0	HEAD
0	0	0	0
0	0	1	1
0	1	0	2
0	1	1	3
1	0	0	4
1	0	1	5
1	1	X	None

0 = Low level 1 = High level X=Don't care

WRITE MODE

The write mode configures the device as a current switch and activates the Write Unsafe (WUS) detection circuitry. Write current is toggled between the X and Y side of the selected head on each high to low transition of the Write Data Input (WDI).

The magnitude of the write current (0-pk) is programmed by an external resistor RWC, connected from pin WC to ground and is given by:

$$I_w = \frac{K}{RWC}$$

where K is the Write Current Constant. In multiple device applications, a single RWC resistor may be made common to all devices.

Power supply fault protection improves data security by disabling the write current generator during a voltage fault or power supply sequencing. Additionally, the write unsafe detection circuitry monitors voltage transitions at the selected head connections and flags any of the conditions listed below as a high level on the open collector output pin, WUS. Two negative transitions on pin WDI, after the fault is corrected, are required to clear the WUS flag.

- Head open
- WDI frequency too low
- Device not selected
- Head center tap open
- Device in read mode
- No write current

To reduce internal power dissipation, an optional external resistor, RCT, given by $RCT \leq 130\Omega \times 40/I_w$ (I_w in mA), is connected between pins VDD1 and VDD2. Otherwise connect pin VDD1 to VDD2.

To initialize the Write Data Flip Flop (WDFF) to pass current through the X-side of the head, pin WDI must be low when the previous read mode was commanded.

READ MODE

The read mode configures the device as a low noise differential amplifier and deactivates the write current generator and write unsafe circuitry. The RDX and RDY outputs are emitter followers and are in phase with the "X" and "Y" head ports. These outputs should be AC coupled to the load. The RDX, RDY common mode voltage is maintained in the write mode, minimizing the transient between write mode and read mode, substantially reducing the write to read recovery time in the subsequent pulse detection circuitry.

IDLE MODE

The idle mode deactivates the internal write current generator, the write unsafe detector, and switches the RDX, RDY outputs into a high impedance state. This facilitates multiple device applications by enabling the read outputs to be wire OR'ed and the write current programming resistor to be common to all devices.

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PIN DESCRIPTIONS

NAME	I/O	DESCRIPTION
HS0-HS2	I	Head Select
\overline{CS}	I	Chip Select: a low level enables device
R/ \overline{W}	I	Read/Write: a high level selects Read mode
WUS	O*	Write Unsafe: a high level indicates an unsafe writing condition
WDI	I	Write Data In: negative transition toggles direction of head current
H0X-H5X H0Y-H5Y	I/O	X,Y head connections
RDX, RDY	O*	X, Y Read Data: differential read signal output
WC	*	Write Current: used to set the magnitude of the write current
VCT	-	Voltage Center Tap: voltage source for head center tap
VCC	-	+5V
VDD1	-	+12V
VDD2	-	Positive power supply for the center-tap voltage source
GND	-	Ground

*When more than one R/W device is used, these signals can be wire OR'ed.

ABSOLUTE MAXIMUM RATINGS

(All voltages referenced to GND. Currents into device are positive.)

PARAMETER		VALUE	UNITS
DC Supply Voltage	VDD1	-0.3 to +14	VDC
DC Supply Voltage	VDD2	-0.3 to +14	VDC
DC Supply Voltage	VCC	-0.3 to +6	VDC
Digital Input Voltage Range	VIN	-0.3 to VCC + 0.3	VDC
Head Port Voltage Range	VH	-0.3 to VDD1 + 0.3	VDC
WUS Pin Voltage Range	Vwus	-0.3 to +14	VDC
Write Current (0-pk)	Iw	60	mA
RDX, RDY Output Current	Io	-10	mA
VCT Output Current	Ivct	-60	mA
WUS Output Current	Iwus	+12	mA
Storage Temperature Range	Tstg	-65 to 150	°C
Lead Temperature PDIP, (10 sec Soldering)		260	°C
Package Temperature PLCC, SO (20 sec Reflow)		215	°C

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RECOMMENDED OPERATING CONDITIONS

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNITS
VDD1 DC Supply Voltage		10.8	12.0	13.2	VDC
VCC DC Supply Voltage		4.5	5.0	5.5	VDC
Lh Head Inductance		5		15	μ H
RD Damping Resistor	32R510A and 32R514 only	500		2000	Ω
RCT* RCT Resistor	Iw = 40 mA	123	130	137	Ω
Iw Write Current (0-pk)		10		40	mA
Tj Junction Temperature Range		+25		+135	$^{\circ}$ C

*For Iw = 40 mA. At other Iw levels refer to Applications Information that follows this specification.

DC CHARACTERISTICS

(Recommended operating conditions apply unless otherwise specified.)

POWER SUPPLY

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNITS
VCC Supply Current	Read/Idle Mode			35	mA
	Write Mode			30	mA
VDD Supply Current (sum of VDD1 and VDD2)	Idle Mode			20	mA
	Read Mode			35	mA
	Write Mode			20 + Iw	mA
Power Dissipation (Tj = +135 $^{\circ}$ C)	Idle Mode			400	mW
	Read Mode			600	mW
	Write Mode, Iw = 40 mA, RCT = 0 Ω			800	mW
	Write Mode, Iw = 40 mA, RCT = 130 Ω			600	mW

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DC CHARACTERISTICS (continued)

DIGITAL I/O

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNITS
VIL Input Low Voltage				0.8	VDC
VIH Input High Voltage		2.0			VDC
IIL Input Low Current	VIL = 0.8V	-0.4			mA
IIH Input High Current	VIH = 2.0V			100	μA
VOL WUS Output Low Voltage	IOL = 8 mA			0.5	VDC
IOH WUS Output High Current	VOH = 5.0V			100	μA

WRITE MODE

VCT Center Tap Voltage	Write Mode 32R510A		6.0		
	Write Mode 32R514		6.7		VDC
Head Current (per side)	Write Mode, 0 ≤ VCC ≤ 3.7V, 0 ≤ VDD1 ≤ 8.7V	-200		200	μA
Write Current Range		10		40	mA
Write Current Constant "K"		2.375		2.625	
Iwc to Head Current Gain			0.99		mA/mA
Unselected Head Leakage Current				85	μA
RDX, RDY Output Offset Voltage	Write/Idle Mode	-20		+20	mV
RDX, RDY Common Mode Output Voltage	Write/Idle Mode		5.3		VDC
RDX, RDY Leakage	RDX, RDY = 6V Write/Idle Mode	-100		100	μA

READ MODE

VCT Center Tap Voltage	Read Mode		4.0		VDC
Head Current (per side)	Read or Idle Mode 0 ≤ VCC ≤ 5.5V 0 ≤ VDD1 ≤ 13.2V	-200		200	μA
Input Bias Current (per side)				45	μA
Output Offset Voltage	Read Mode 32R510A	-440		+440	mV
	Read Mode 32R514	-615		+615	mV
Common Mode Output Voltage	Read Mode	4.5		6.5	VDC

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DYNAMIC CHARACTERISTICS AND TIMING

$I_w = 35 \text{ mA}$, $L_h = 10 \mu\text{H}$, $R_d = 750 \Omega$ 32R514 only, $f(\text{WDI}) = 5 \text{ MHz}$, $CL(\text{RDX}, \text{RDY}) \leq 20 \text{ pF}$. Recommended operating conditions apply unless otherwise specified.

WRITE MODE

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNITS
Differential Head Voltage Swing		7.0			V(pk)
Unselected Head Transient Current				2	mA(pk)
Differential Output Capacitance				15	pF
Differential Output Resistance	32R510A and 32R514	10K			Ω
	32R510AR and 32R514R	600		960	Ω
WDI Transition Frequency	WUS = low	250			KHz

READ MODE

Differential Voltage Gain	32R510A	$V_{in} = 1 \text{ mVpp @ } 300 \text{ kHz}$ $Z_L(\text{RDX}), Z_L(\text{RDY}) = 1 \text{ k}\Omega$	85		115	V/V
	32R514	$V_{in} = 1 \text{ mVpp @ } 300 \text{ kHz}$ $Z_L(\text{RDX}), Z_L(\text{RDY}) = 1 \text{ k}\Omega$	125		175	V/V
Dynamic Range		DC Input Voltage, V_i , Where Gain Falls by 10% $V_{in} = V_i + 0.5 \text{ mVpp}$ @ 300 kHz	-2		+2	mV
Bandwidth (-3dB)		$ Z_s < 5\Omega$, $V_{in} = 1 \text{ mVpp}$	30			MHz
Input Noise Voltage		BW = 15 MHz, $L_h = 0$, $R_h = 0$			1.5	nV/ $\sqrt{\text{Hz}}$
Differential Input Capacitance		$f = 5 \text{ MHz}$			20	pF
Differential Input Resistance		32R514, $f = 5 \text{ MHz}$	3.2K			Ω
		32R514R, $f = 5 \text{ MHz}$	500		1000	Ω
		32R510A, $f = 5 \text{ MHz}$	2K			Ω
		32R510AR, $f = 5 \text{ MHz}$	460		860	Ω
Common Mode Rejection Ratio		$V_{cm} = V_{CT} + 100 \text{ mVpp}$ @ 5 MHz	50			dB
Power Supply Rejection Ratio		100 mVpp @ 5 MHz on VDD1, VDD2 or VCC	45			dB
Channel Separation		Unselected Channels: $V_{in} = 100 \text{ mVpp @ } 5 \text{ MHz}$; Selected Channel: $V_{in} = 0 \text{ mVpp}$	45			dB
Single Ended Output Resistance		$f = 5 \text{ MHz}$			30	Ω
Output Current		AC Coupled Load, RDX to RDY	± 2.1			mA

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DYNAMIC CHARACTERISTICS AND TIMING (continued)

SWITCHING CHARACTERISTICS

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNITS
R/W To Write Mode	Delay to 90% of Write Current			1.0	μs
R/W to Read Mode	Delay to 90% of 100 mV, 10 MHz Read Signal Envelope or to 90% decay of Write Current			1.0	μs
\overline{CS} to Select	Delay to 90% of Write Current or to 90% of 100 mV, 10 MHz Read Signal Envelope			1.0	μs
\overline{CS} to Unselect	Delay to 90% Decay of Write Current			1.0	μs
HS0 - HS2 to any head	Delay to 90% of 100mV 10 MHz Read Signal Envelope			1.0	μs
WUS, Safe to Unsafe - TD1	I _w = 35 mA, see Figure 1	1.6		8.0	μs
WUS, Unsafe to Safe - TD2	I _w = 35 mA, see Figure 1			1.0	μs
Head Current (L _h = 0 μH, R _h = 0Ω, see Figure 1)					
Prop. Delay - TD3	From 50% Points			25	ns
Asymmetry	WDI has 50% Duty Cycle and 1ns Rise/Fall Time			2	ns
Rise/Fall Time	10% - 90% Points			20	ns

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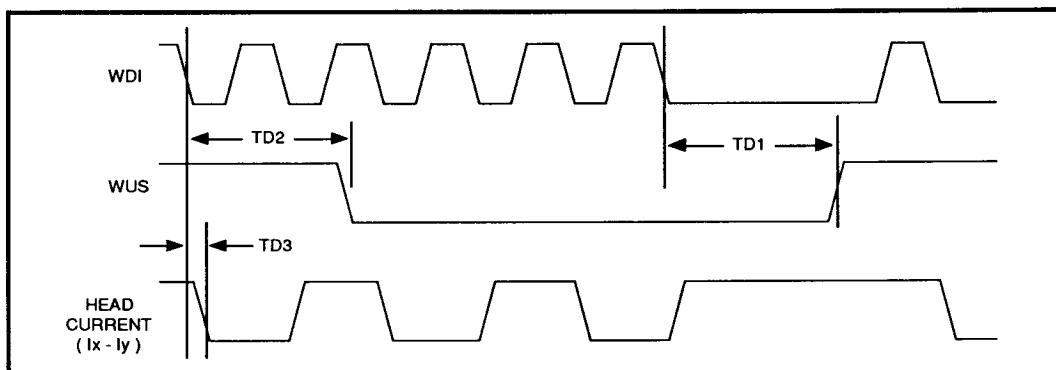


FIGURE 1: Write Mode Timing Diagram

APPLICATIONS INFORMATION

The specifications, provided in the data section, account for the worst case values of each parameter taken individually. In actual operation, the effects of worst case conditions on many parameters correlate. Tables 3 & 4 demonstrate this for several key parameters. Notice that under the conditions of worst case input noise, the higher read back signal resulting from the higher input impedance can compensate for the higher input noise. Accounting for this correlation in your analysis will be more representative of actual performance.

TABLE 3: Key Parameters Under Worst Case Input Noise Conditions

PARAMETER		T _j =25°C	T _j =135°C	UNITS
Inputs Noise Voltage (max.)		1.1	1.5	nV/√Hz
Differential Input Resistance (min.)	32R514R	850	1000	Ω
	32R514	15.4	29.4	KΩ
Differential Input Capacitance (max.)		11.6	10.8	pF

TABLE 4: Key Parameters Under Worst Case Input Impedance Conditions

PARAMETER		T _j =25°C	T _j =135°C	UNITS
Inputs Noise Voltage (max.)		0.92	1.2	nV/√Hz
Differential Input Resistance (min.)	32R514R	500	620	Ω
	32R514	3.2	6.1	KΩ
Differential Input Capacitance (max.)		10.1	10.3	pF

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APPLICATIONS INFORMATION (continued)

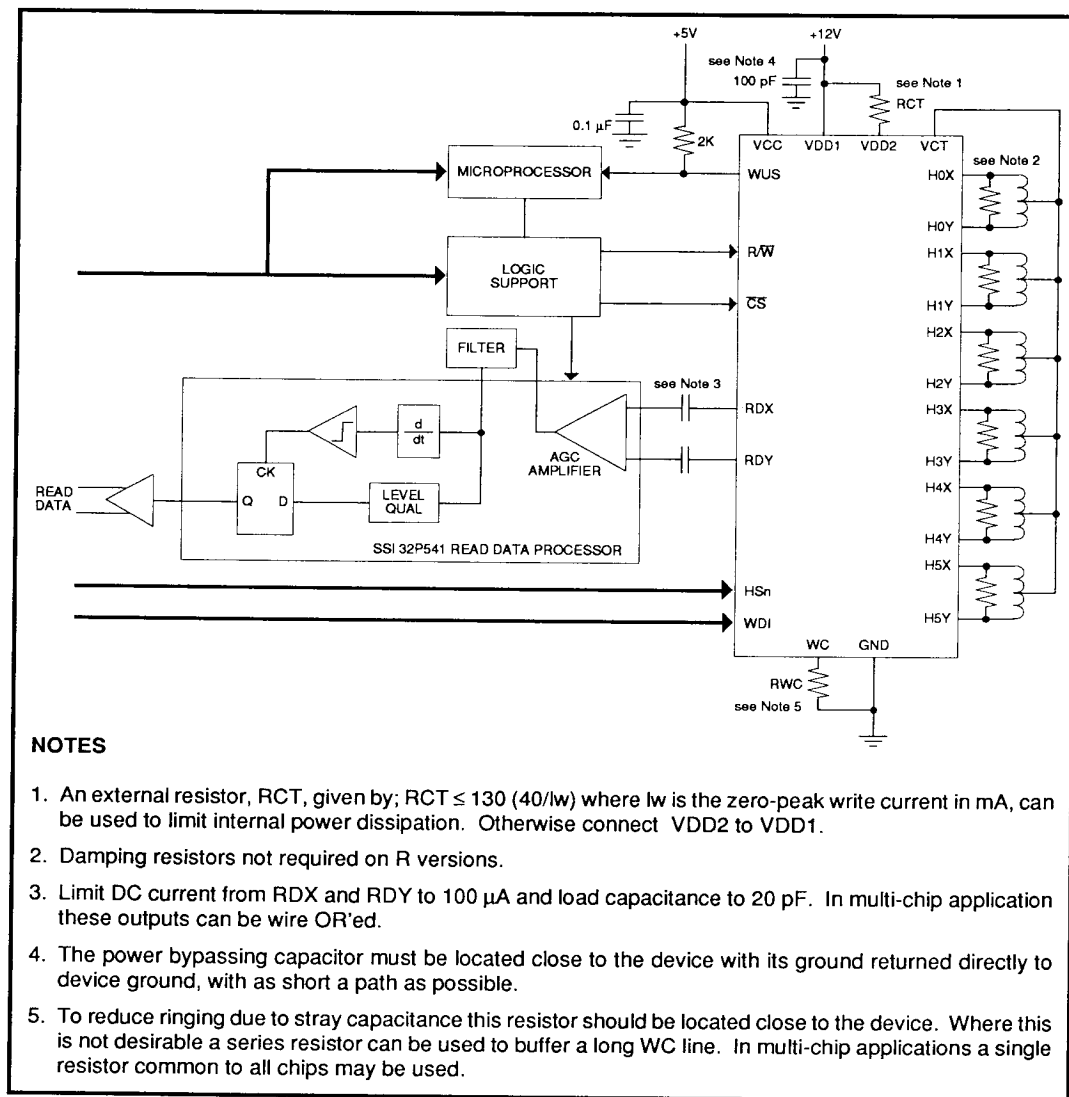
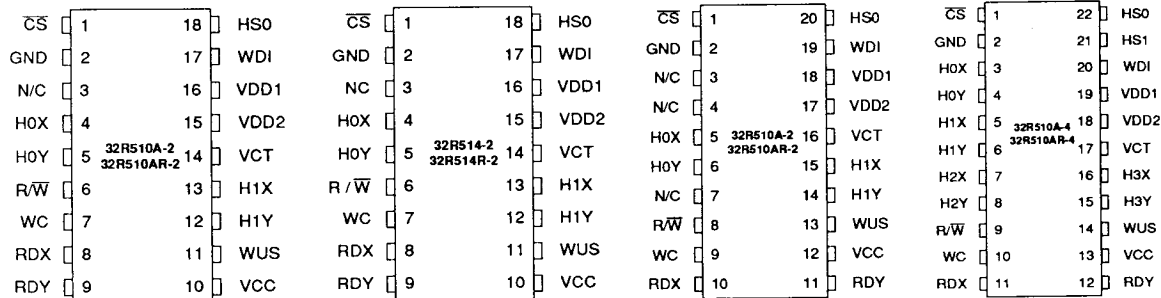


FIGURE 2: Typical Application Diagram

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PACKAGE PIN DESIGNATIONS (TOP VIEW)

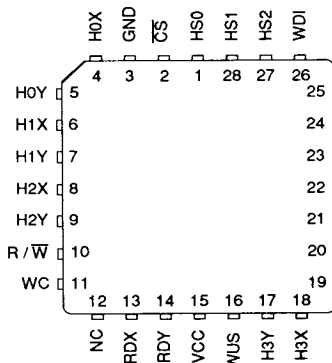


18-LEAD PDIP

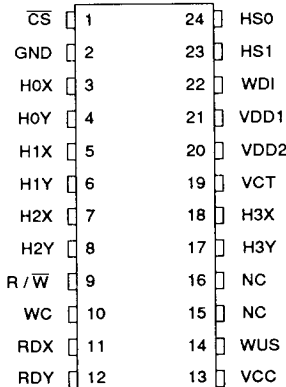
18-LEAD SOL

20-LEAD SOL

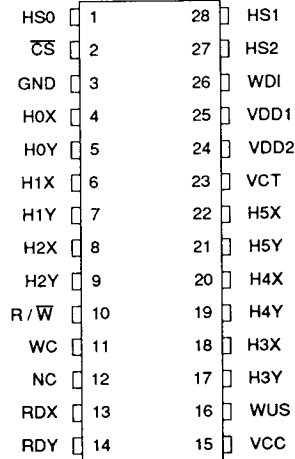
22-LEAD PDIP



6-CHANNEL
28-LEAD PLCC



4-CHANNEL
24-LEAD SOL, FLATPACK



6-CHANNEL
28-LEAD PDIP,
FLATPACK, SOL

THERMAL CHARACTERISTICS

PACKAGE		θ_{ja}
18-Lead	PDIP	140°C/W
18-Lead	SOL	100°C/W
20-Lead	SOL	95°C/W
22-Lead	PDIP	65°C/W
24-Lead	Flatpack	105°C/W
24-Lead	SOL	80°C/W
28-Lead	PLCC	65°C/W
28-Lead	Flatpack	100°C/W
28-Lead	PDIP	55°C/W
28-Lead	SOL	70°C/W

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ORDERING INFORMATION

PART DESCRIPTION	ORDER NO.	PKG. MARK
SSI 32R510A		
2-Channel PDIP	SSI 32R510A-2P	32R510A-2P
2-Channel SOL	SSI 32R510A-2L	32R510A-2L
4-Channel SOL	SSI 32R510A-4CL	32R510A-4CL
4-Channel Flatpack	SSI 32R510A-4F	32R510A-4F
4-Channel PDIP	SSI 32R510A-4CP	32R510A-4CP
6-Channel PDIP	SSI 32R510A-6CP	32R510A-6CP
6-Channel SOL	SSI 32R510A-6CL	32R510A-6CL
6-Channel Flatpack	SSI 32R510A-6F	32R510A-6F
6-Channel PLCC	SSI 32R510A-6CH	32R510A-6CH
SSI 32R510AR with Internal Damping Resistor		
2-Channel PDIP	SSI 32R510AR-2P	32R510AR-2P
2-Channel SOL	SSI 32R510AR-2L	32R510AR-2L
4-Channel SOL	SSI 32R510AR-4CL	32R510AR-4CL
4-Channel Flatpack	SSI 32R510AR-4F	32R510AR-4F
4-Channel PDIP	SSI 32R510AR-4CP	32R510AR-4CP
6-Channel PDIP	SSI 32R510AR-6CP	32R510AR-6CP
6-Channel SOL	SSI 32R510AR-6CL	32R510AR-6CL
6-Channel Flatpack	SSI 32R510AR-6F	32R510AR-6F
6-Channel PLCC	SSI 32R510AR-6CH	32R510AR-6CH
SSI 32R514 Read/Write IC		
2-Channel SOL	SSI 32R514-2CL	32R514-2CL
4-Channel SOL	SSI 32R514-4CL	32R514-4CL
6-Channel SOL	SSI 32R514-6CL	32R514-6CL
6-Channel PLCC	SSI 32R514-6CH	32R514-6CH
SSI 32R514R Read/Write IC-with internal damping resistors		
2-Channel SOL	SSI 32R514R-2CL	32R514R-2CL
4-Channel SOL	SSI 32R514R-4CL	32R514R-4CL
6-Channel SOL	SSI 32R514R-6CL	32R514R-6CL
6-Channel PLCC	SSI 32R514R-6CH	32R514R-6CH

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